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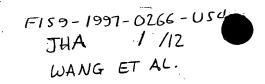
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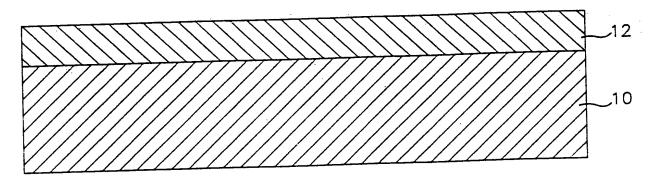


FIG. 1

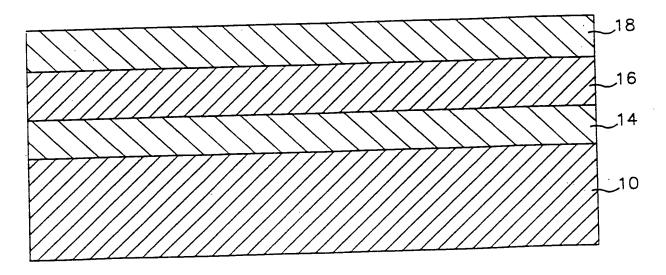


FIG. 2a

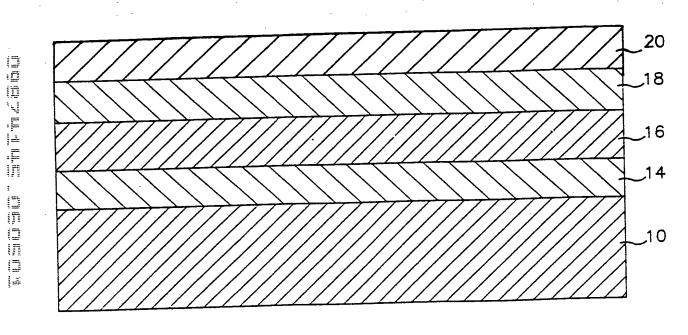
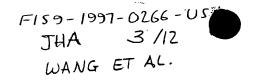


FIG. 2b



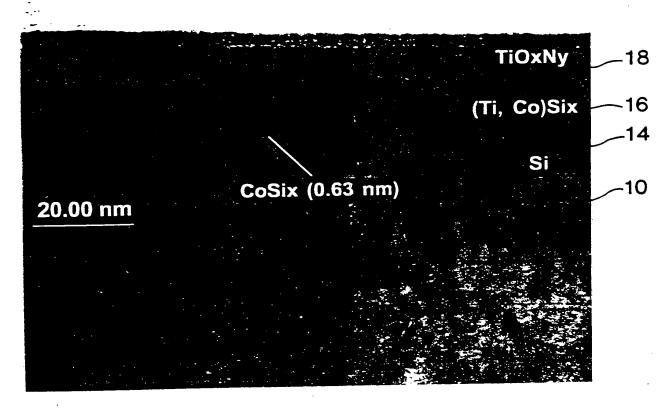


FIG. 3

JHA 4/12

WANG ET AL.

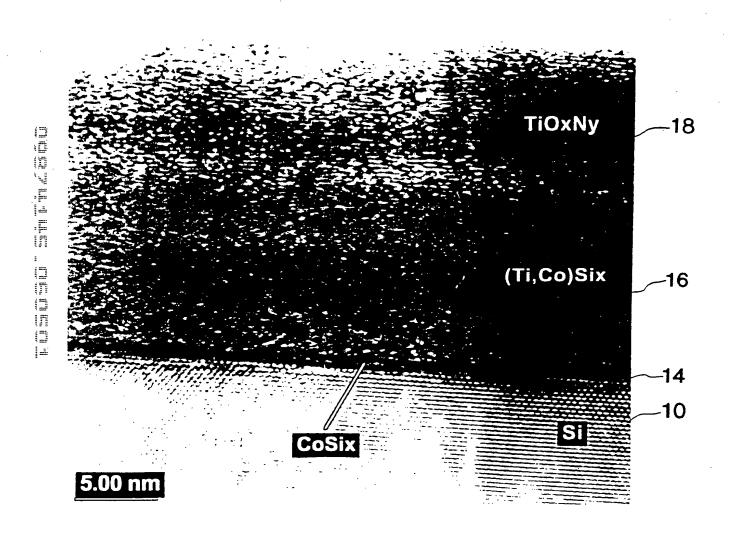


FIG. 4

JHA 5/12 WANG ET AL.

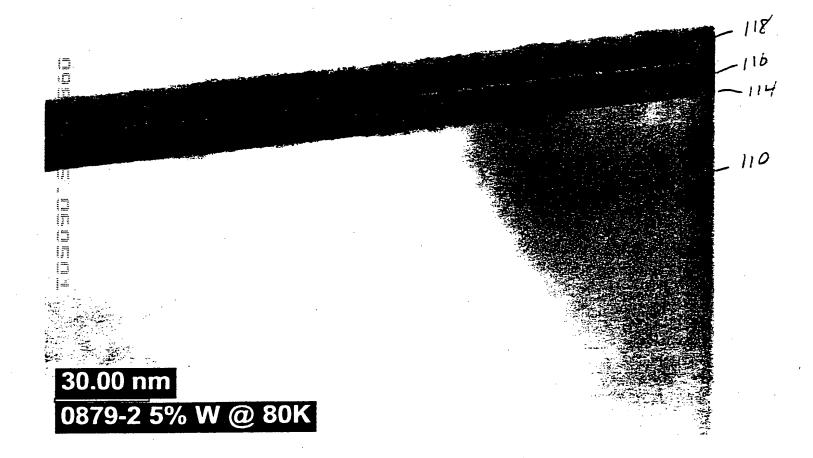


FIGURE 5

JHA 6/12

WANG ET AL.

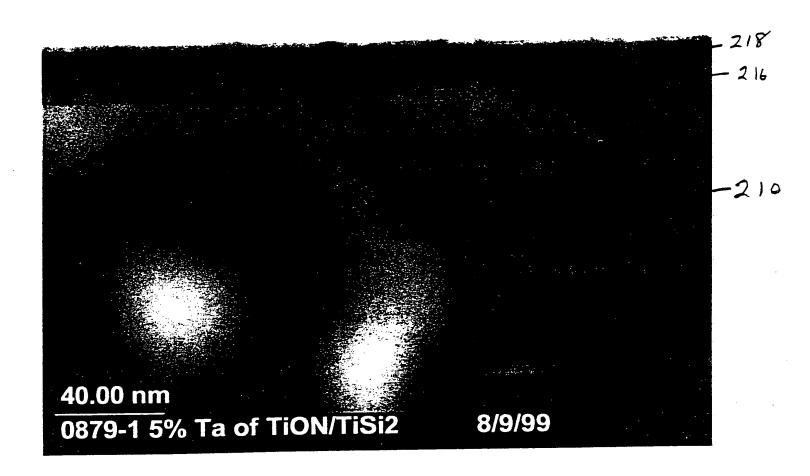


FIGURE 6

JHA 7/12 WANG ET AL.

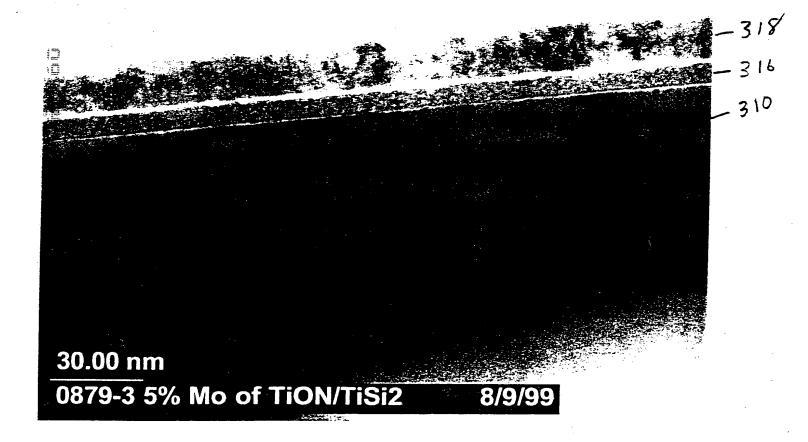


FIGURE 7

THA 8/12 WANG ET AL.

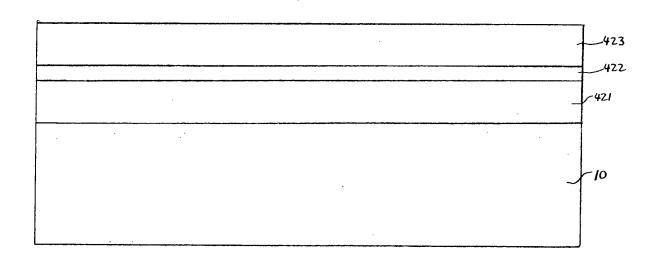


FIG. 8

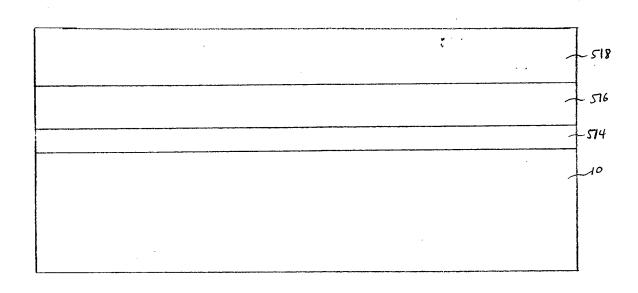


FIG.9



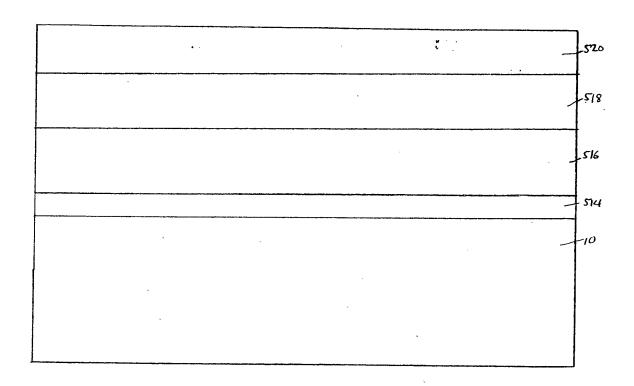


FIG. 10

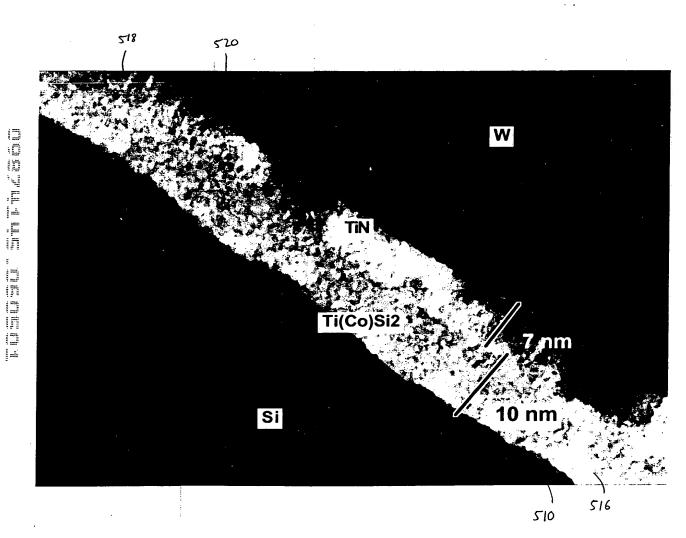
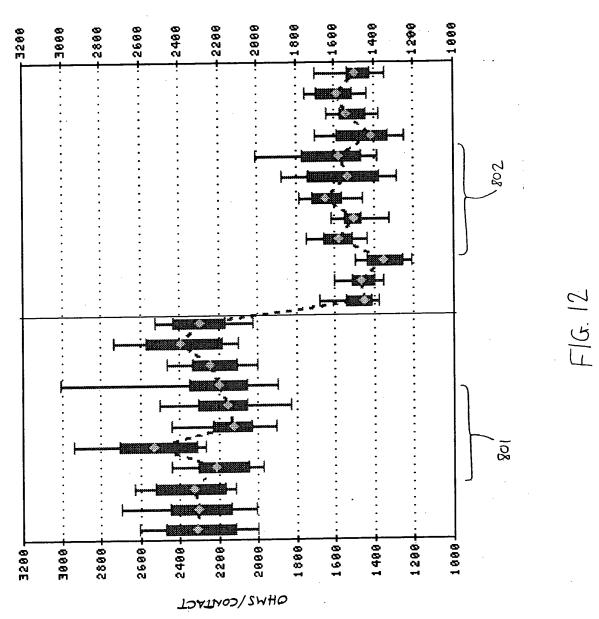


FIG. 11

F159-1997-0266-US4 JAA 12/12 WANG ET AL.



Contact resistance